

<b>Notice of References Cited</b>	Application/Control No. 10/801,762		Applicant(s)/Patent Under Reexamination UCHIDA ET AL.	
	Examiner Binh-An D. Nguyen		Art Unit 3714	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,356,288 B1	03-2002	Freeman et al.	715/867
*	B	US-6,767,287 B1	07-2004	Mcquaid et al.	463/42
*	C	US-6,527,641 B1	03-2003	Sinclair et al.	463/39
*	D	US-4,958,835	09-1990	Tashiro et al.	463/42
*	E	US-4,572,509	02-1986	Sitrick, David H.	463/31
*	F	US-4,372,558	02-1983	Shimamoto et al.	463/41
*	G	US-5,964,660 A	10-1999	James et al.	463/1
*	H	US-5,956,485 A	09-1999	Perlman, Stephen G.	709/204
*	I	US-5,908,467 A	06-1999	Barrett et al.	709/218
*	J	US-6,152,824 A	11-2000	Rothschild et al.	463/40
*	K	US-5,618,045 A	04-1997	Kagan et al.	463/40
*	L	US-4,521,014	06-1985	Sitrick, David H.	463/31
*	M	US-6,500,070 B1	12-2002	Tomizawa et al.	463/43

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.